$\frac{\text{MOSFET}}{\text{D}^2\text{PAK}} - \text{N-Channel,}$ $\frac{\text{D}^2\text{PAK}}{\text{45 A, 60 V, 26 m}\Omega}$

Designed for low voltage, high speed switching applications in power supplies, converters and power motor controls and bridge circuits.

Features

- Higher Current Rating
- Lower R_{DS(on)}
- Lower V_{DS(on)}
- Lower Capacitances
- Lower Total Gate Charge
- Tighter V_{SD} Specification
- Lower Diode Reverse Recovery Time
- Lower Reverse Recovery Stored Charge
- AEC-Q101 Qualified and PPAP Capable NTBV45N06
- These Devices are Pb-Free and are RoHS Compliant

Typical Applications

- Power Supplies
- Converters
- Power Motor Controls
- Bridge Circuits

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V_{DSS}	60	Vdc
Drain-to-Gate Voltage (R _{GS} = 10 MΩ)	V_{DGR}	60	Vdc
Gate–to–Source Voltage - Continuous - Non–Repetitive (t _p ≤10 ms)	V _{GS} V _{GS}	±20 ±30	Vdc
$ \begin{array}{lll} \text{Drain Current} & -\text{ Continuous } \textcircled{0} T_A = 25^{\circ}\text{C} \\ -\text{ Continuous } \textcircled{0} T_A = 100^{\circ}\text{C} \\ -\text{ Single Pulse } (t_p \leq 10 \mu\text{s}) \end{array} $	I _D I _D I _{DM}	45 30 150	Adc Apk
Total Power Dissipation @ T _A = 25°C Derate above 25°C Total Power Dissipation @ T _A = 25°C (Note 1) Total Power Dissipation @ T _A = 25°C (Note 2)	P _D	125 0.83 3.2 2.4	\$ % \ 0 0
Operating and Storage Temperature Range	T _J , T _{stg}	-55 to +175	°C
Single Pulse Drain–to–Source Avalanche Energy – Starting $T_J=25^{\circ}C$ ($V_{DD}=50$ Vdc, $V_{GS}=10$ Vdc, $RG=25$ Ω , $I_{L(pk)}=40$ A, $L=0.3$ mH, $V_{DS}=60$ Vdc)	E _{AS}	240	mJ
Thermal Resistance - Junction-to-Case - Junction-to-Ambient (Note 1) - Junction-to-Ambient (Note 2)	$egin{array}{c} R_{ heta JC} \ R_{ heta JA} \ R_{ heta JA} \end{array}$	1.2 46.8 63.2	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8 in from case for 10 seconds	T _L	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. When surface mounted to an FR4 board using 1 in pad size, (Cu Area 1.127 in²).

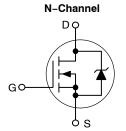


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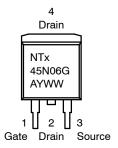
45 AMPERES, 60 VOLTS

 $R_{DS(on)} = 26 \text{ m}\Omega$





MARKING DIAGRAMS & PIN ASSIGNMENTS



NTx45N06 = Device Code x = B or P

A = Assembly Location

Y = Year WW = Work Week G = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 3 of this data sheet.

2.	When surface mounted to an FR4 board using the minimum recommended pad size, (Cu Area 0.412 in ²).

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

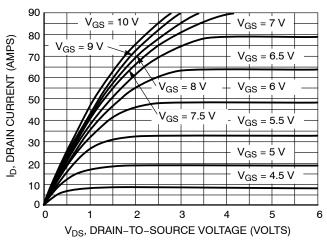
C	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS			•	•		•
Drain-to-Source Breakdown (V _{GS} = 0 Vdc, I _D = 250 μAd Temperature Coefficient (Posit	V _{(BR)DSS}	60 -	70 57	- -	Vdc mV/°C	
Zero Gate Voltage Drain Curre $(V_{DS} = 60 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$ $(V_{DS} = 60 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$	I _{DSS}	- -	- -	1.0 10	μAdc	
Gate-Body Leakage Current (V _{GS} = ±20 Vdc, V _{DS} = 0 Vdc)	I _{GSS}	-	_	±100	nAdc
ON CHARACTERISTICS (Note	3)					
Gate Threshold Voltage (Note $(V_{DS} = V_{GS}, I_D = 250 \mu Adc)$ Threshold Temperature Coeffi	V _{GS(th)}	2.0	2.8 7.2	4.0 -	Vdc mV/°C	
Static Drain-to-Source On-R (V _{GS} = 10 Vdc, I _D = 22.5 Ac	R _{DS(on)}	-	21	26	mΩ	
Static Drain-to-Source On-Vo $(V_{GS} = 10 \text{ Vdc}, I_D = 45 \text{ Adc})$ $(V_{GS} = 10 \text{ Vdc}, I_D = 22.5 \text{ Adc})$	V _{DS(on)}	- -	0.93 0.93	1.4 -	Vdc	
Forward Transconductance (N	9 _{FS}	-	16.6	-	mhos	
DYNAMIC CHARACTERISTICS	3					
Input Capacitance		C _{iss}	-	1224	1725	pF
Output Capacitance	(V _{DS} = 25 Vdc, V _{GS} = 0 Vdc, f = 1.0 MHz)	C _{oss}	-	345	485	
Transfer Capacitance	,	C _{rss}	_	76	160	
SWITCHING CHARACTERISTI	CS (Note 4)					
Turn-On Delay Time		t _{d(on)}	-	10	25	ns
Rise Time	(V _{DD} = 30 Vdc, I _D = 45 Adc,	t _r	-	101	200	
Turn-Off Delay Time	$V_{GS} = 10 \text{ Vdc}, R_G = 9.1 \Omega) \text{ (Note 3)}$	$t_{d(off)}$	-	33	70	
Fall Time		t _f	-	106	220	1
Gate Charge		Q _T	-	33	46	nC
	$(V_{DS} = 48 \text{ Vdc}, I_D = 45 \text{ Adc}, V_{GS} = 10 \text{ Vdc}) \text{ (Note 3)}$	Q ₁	-	6.4	-	
	VGS = 10 Vd0) (11010 0)	Q ₂	-	15	-	
SOURCE-DRAIN DIODE CHAI	RACTERISTICS					
Forward On-Voltage	$(I_S = 45 \text{ Adc}, V_{GS} = 0 \text{ Vdc}) \text{ (Note 3)}$ $(I_S = 45 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J = 150^{\circ}\text{C})$	V_{SD}	-	1.08 0.93	1.2 -	Vdc
Reverse Recovery Time	(I _S = 45 Adc, V _{GS} = 0 Vdc, dI _S /dt = 100 A/µs) (Note 3)	t _{rr}	-	53.1	-	ns
		t _a	-	36	-	
	2.5/αι = 100 / γμο/ (1010 0)	t _b	-	16.9	-	
Reverse Recovery Stored Charge		Q _{RR}	-	0.087	_	μC

ORDERING INFORMATION

Device	Package	Shipping [†]
NTB45N06T4G	D ² PAK (Pb-Free)	800 / Tape & Reel
NTBV45N06T4G	D ² PAK (Pb-Free)	800 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

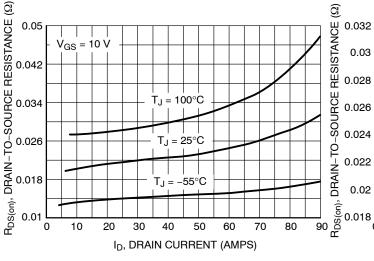


80 _{lo}, DRAIN CURRENT (AMPS) 70 60 50 40 30 $T_J = 25^{\circ}C$ 20 $T_J = 100^{\circ}C$ 10 $T_J = -55^{\circ}C$ 0 5.5 6 6.5 V_{GS}, GATE-TO-SOURCE VOLTAGE (VOLTS)

 $V_{DS} > = 10 \text{ V}$

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



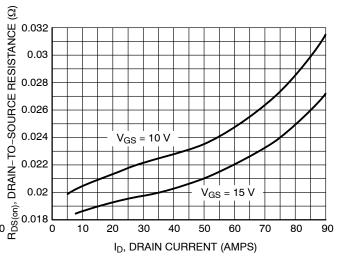
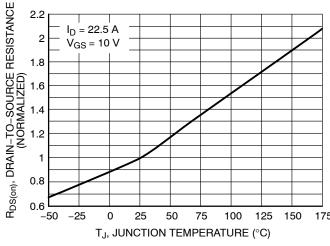


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



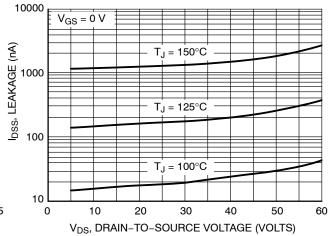


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

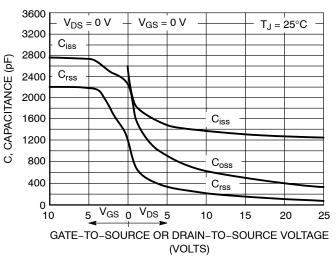


Figure 7. Capacitance Variation

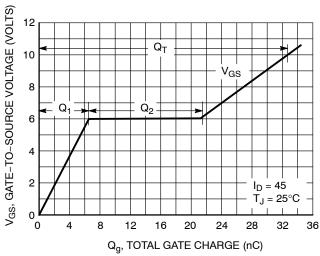


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

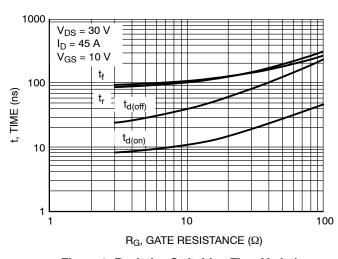


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

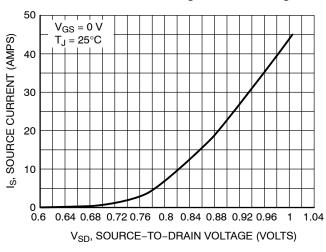


Figure 10. Diode Forward Voltage vs. Current

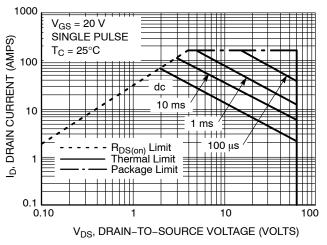


Figure 11. Maximum Rated Forward Biased Safe Operating Area

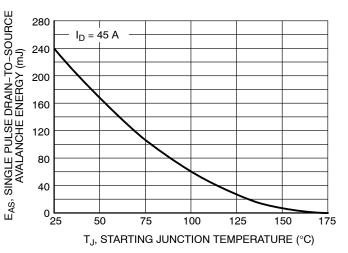


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

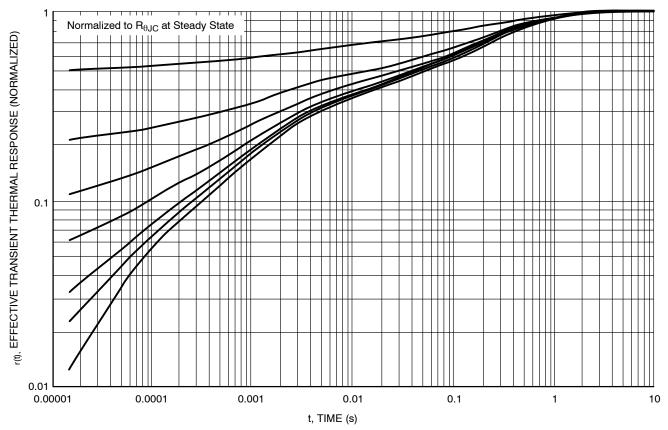


Figure 13. Thermal Response

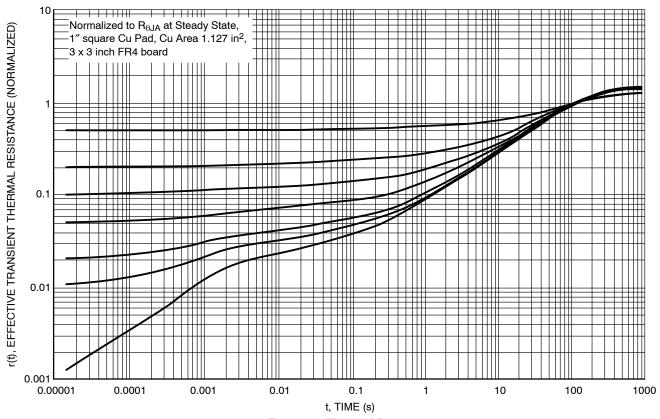


Figure 14. Thermal Response

MECHANICAL CASE OUTLINE

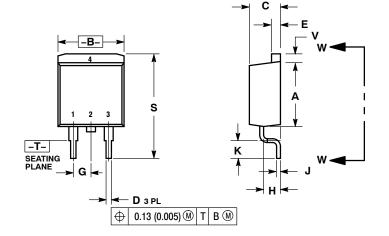




D²PAK 3 CASE 418B-04 **ISSUE L**

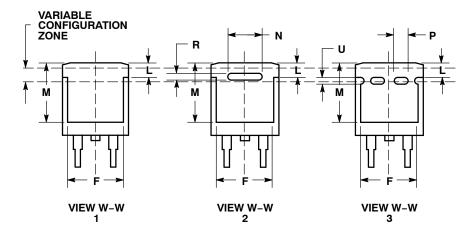
DATE 17 FEB 2015

SCALE 1:1



- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: INCH.
- 3. 418B-01 THRU 418B-03 OBSOLETE, NEW STANDARD 418B-04.

	INCHES		MILLIMETER	
DIM	MIN	MAX	MIN	MAX
Α	0.340	0.380	8.64	9.65
В	0.380	0.405	9.65	10.29
C	0.160	0.190	4.06	4.83
D	0.020	0.035	0.51	0.89
Е	0.045	0.055	1.14	1.40
F	0.310	0.350	7.87	8.89
G	0.100 BSC		2.54 BSC	
Н	0.080	0.110	2.03	2.79
7	0.018	0.025	0.46	0.64
Κ	0.090	0.110	2.29	2.79
L	0.052	0.072	1.32	1.83
M	0.280	0.320	7.11	8.13
N	0.197 REF		5.00 REF	
Р	0.079 REF		2.00 REF	
R	0.039 REF		0.99 REF	
S	0.575	0.625	14.60	15.88
٧	0.045	0.055	1.14	1.40



STYLE 1: PIN 1. BASE 2. COLLECTOR
3. EMITTER
4. COLLECTOR STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN STYLE 3: PIN 1. ANODE 2. CATHODE 3. ANODE 4. CATHODE

STYLE 4:

PIN 1. GATE
2. COLLECTOR
3. EMITTER
4. COLLECTOR

STYLE 5:

PIN 1. CATHODE 2. ANODE 3. CATHODE 4. ANODE

STYLE 6:

PIN 1. NO CONNECT
2. CATHODE
3. ANODE
4. CATHODE

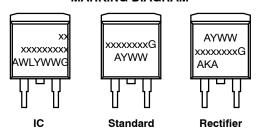
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DATE 17 FEB 2015

GENERIC MARKING DIAGRAM*



xx = Specific Device Code A = Assembly Location

 WL
 = Wafer Lot

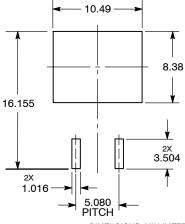
 Y
 = Year

 WW
 = Work Week

 G
 = Pb-Free Package

 AKA
 = Polarity Indicator

SOLDERING FOOTPRINT*



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^{*}This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot " ■", may or may not be present.

^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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